## Notice of References Cited Application/Control No. 10/605,535 Examiner Sebastiano Passaniti Applicant(s)/Patent Under Reexamination WIELAND ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*	-	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,334,818	01-2002	Cameron et al.	473/332
	В	US-5,303,922	04-1994	Lo, Kun-Nan	473/330
	С	US-6,328,661	12-2001	Helmstetter et al.	473/324
	D	US-6,238,302	05-2001	Helmstetter et al.	473/340
	E	US-5,713,800	02-1998	Su, Charles	473/342
	F	US-5,104,457	04-1992	Viljoen et al.	473/350
	G	US-6,743,117	06-2004	Gilbert, Peter J.	473/332
	н	US-6,616,546	09-2003	Cho, Jung Hyun	473/329
	ı	US-6,554,722	04-2003	Erickson et al.	473/334
	J	US-5,674,132	10-1997	Fisher, Dale P.	473/290
	К	US-6,638,183	10-2003	Takeda, Hitoshi	473/335
	L	US-6,688,989	02-2004	Best, Christopher B.	473/332
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	٧						
	W						
	х						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.